

RoHS COMPLIANT HALOGEN FREE

2SK601-VB Datasheet

N-Channel 100 V (D-S) MOSFET

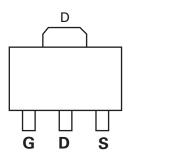
| MOSFET PRODUCT SUMMARY | | | | | | | | |
|------------------------|----------------------------------|-------------------------------------------|--------|--|--|--|-------------------------------------|--|
| V _{DS} (V) | R _{DS(on)} (Ω) Typ. | _{S(on)} (Ω) Typ. $I_D (A)^a Q_g$ | | | | | /p. I _D (A) ^a | |
| | 0.102 at V _{GS} = 10 V | 4.2 | | | | | | |
| 100 | 0.120 at V _{GS} = 6 V | 3.8 | 2.9 nC | | | | | |
| | 0.125 at V _{GS} = 4.5 V | 3.6 | | | | | | |

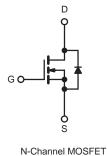
FEATURES

- TrenchFET[®] Power MOSFET
- 100 % Rg and UIS Tested



- DC/DC Converters / Boost Converters
- · Load Switch
- LED Backlighting in LCD TVs
- · Power Management for Mobile Computing





| ABSOLUTE MAXIMUM RATINGS ($T_A = 25 \text{ °C}$, unless otherwise noted) | | | | | | | |
|-----------------------------------------------------------------------------------|-----------------------------------|-----------------|----------------------|----|--|--|--|
| Parameter | Symbol | Limit | Unit | | | | |
| Drain-Source Voltage | V _{DS} | 100 | V | | | | |
| Gate-Source Voltage | V _{GS} | ± 20 | v | | | | |
| | T _C = 25 °C | | 4.2 | | | | |
| Continuous Drain Current ($T_1 = 150 \ ^{\circ}C$) | T _C = 70 °C | ID | 3.5 | | | | |
| Continuous Drain Current (1j = 150°C) | T _A = 25 °C | U | 3.2 ^{b,c} | | | | |
| | T _A = 70 °C | | 2.8 ^{b,c} | A | | | |
| Pulsed Drain Current (t = 300 µs) | I _{DM} | 15 | | | | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | ۱ _S | 2.1 | | | | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | '5 | 1 ^{b, c} | | | | |
| Single Pulse Avalanche Current | L = 0.1 mH | I _{AS} | 3 | | | | |
| Single Pulse Avalanche Energy | L = 0.1 mm | E _{AS} | 0.45 | mJ | | | |
| | T _C = 25 °C | | 2.5 | | | | |
| Maximum Power Dissipation | T _C = 70 °C | Pn | 1.6 | w | | | |
| Maximum rower dissipation | T _A = 25 °C | . 0 | 1.25 ^{b, c} | V | | | |
| | T _A = 70 °C | | 0.8 ^{b, c} | | | | |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | - 55 to 150 | °C | | | | |

| THERMAL RESISTANCE RATINGS | | | | | | | | |
|---------------------------------------------|----------------|-------------------|---------|------|------|--|--|--|
| Parameter | Symbol Typical | | Maximum | Unit | | | | |
| Maximum Junction-to-Ambient ^{b, d} | ≤ 5 s | R _{thJA} | 75 | 100 | °C/W | | | |
| Maximum Junction-to-Foot (Drain) | Steady State | R _{thJF} | 40 | 50 | 0/11 | | | |

Notes:

a. Based on T_C = 25 °C.
b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 166 °C/W.

| MOSFET SPECIFICATIONS | $(T_{J} = 25 \ ^{\circ}C)$ | , unless otherwise noted) | | | | | |
|-----------------------------------------------|-----------------------------------|---------------------------------------------------------------------------------|----------|-------|-------|----------|--|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
| Static | | | | | | - | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 V, I_{D} = 250 \mu A$ | 100 | | | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 250 μA | | 59 | | mV/°C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | | | - 4.8 | | 1110/ 0 | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ | 1.2 | | 3 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0$ V, $V_{GS} = \pm 20$ V | | | ± 100 | nA | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$ | | | - 1 | μA | |
| Zero Gale Voltage Dialit Guitern | ·D22 | V_{DS} = 100 V, V_{GS} = 0 V, T_{J} = 55 °C | | | - 10 | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5$ V, V_{GS} = 10 V | 5 | | | Α | |
| | | $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 2 \text{ A}$ | | 0.102 | | Ω | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = 6 V, I _D = 1 A | | 0.120 | | | |
| | | V _{GS} = 4.5 V, I _D = 1 A | | 0.125 | | | |
| Forward Transconductance ^a | 9 _{fs} | $V_{DS} = 20 \text{ V}, \text{ I}_{D} = 2 \text{ A}$ | | 5 | | S | |
| Dynamic ^b | 11 | | <u> </u> | 1 | I | I | |
| Input Capacitance | C _{iss} | | | 196 | | pF | |
| Output Capacitance | C _{oss} | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$ | | 67 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 14 | | | |
| Takal Qaka Okamu | | $V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 2.2 \text{ A}$ | | 5.2 | 10.4 | nC | |
| Total Gate Charge | Q _g Q _{gs} | | | 2.9 | 5.8 | | |
| Gate-Source Charge | | V_{DS} = 50 V, V_{GS} = 4.5 V, I_D = 2.2 A | | 1 | | | |
| Gate-Drain Charge | Q _{gd} | | | 1.4 | | | |
| Gate Resistance | R _g | f = 1 MHz | 0.9 | 4.3 | 8.6 | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 40 | 60 | - ns | |
| Rise Time | t _r | V_{DD} = 50 V, R_L = 27.7 Ω | | 68 | 102 | | |
| Turn-Off Delay Time | t _{d(off)} | $\rm I_D$ = 1.8 A, $\rm V_{GEN}$ = 4.5 V, $\rm R_g$ = 1 Ω | | 14 | 21 | | |
| Fall Time | t _f | | | 20 | 30 | | |
| Turn-On Delay Time | t _{d(on)} | | | 8 | 16 | | |
| Rise Time | t _r | | | 10 | 20 | 1 | |
| Turn-Off Delay Time | t _{d(off)} | ${ m I}_{ m D}$ = 1.8 A, ${ m V}_{ m GEN}$ = 10 V, ${ m R}_{ m g}$ = 1 Ω | | 10 | 20 | 1 | |
| Fall Time | t _f | | | 7 | 14 | - | |
| Drain-Source Body Diode Characterist | cs | | <u> </u> | 1 | I | I | |
| Continuous Source-Drain Diode Current | ۱ _S | T _C = 25 °C | | | - 2.1 | _ | |
| Pulse Diode Forward Current ^a | I _{SM} | | | | - 8 | A | |
| Body Diode Voltage | V _{SD} | I _S = 1.8 A | | - 0.8 | - 1.2 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | | 1 | 23 | 35 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 1.8 A, dl/dt = 100 A/μs, | | 21 | 32 | nC | |
| Reverse Recovery Fall Time | ta | T _J = 25 °C | | 17 | | | |
| Reverse Recovery Rise Time | t _b | | | 6 | | ns | |

Notes:

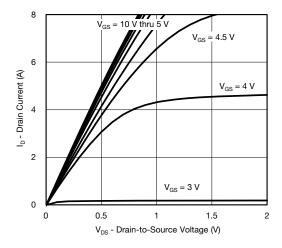
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

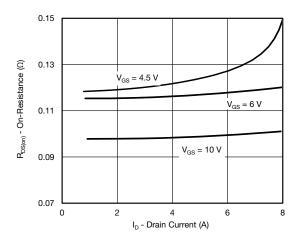
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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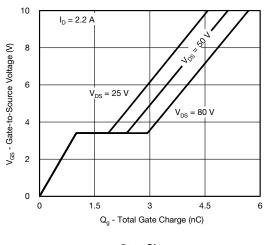




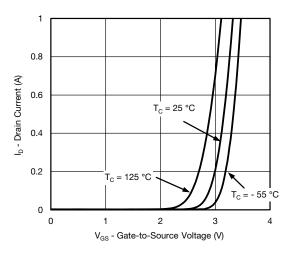




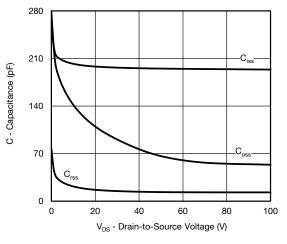
On-Resistance vs. Drain Current and Gate Voltage



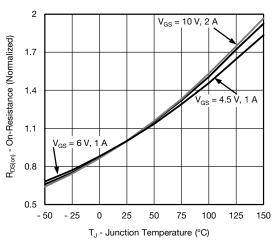
Gate Charge



Transfer Characteristics

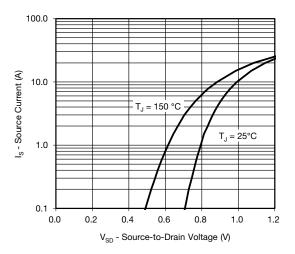




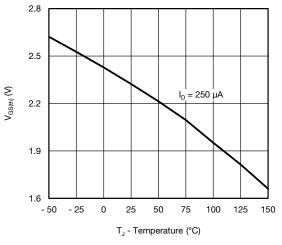


On-Resistance vs. Junction Temperature

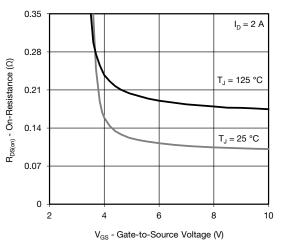




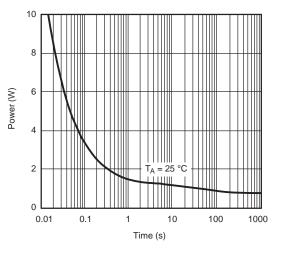




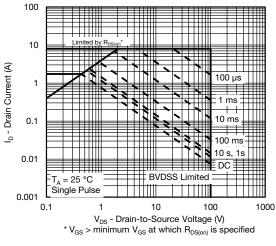
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

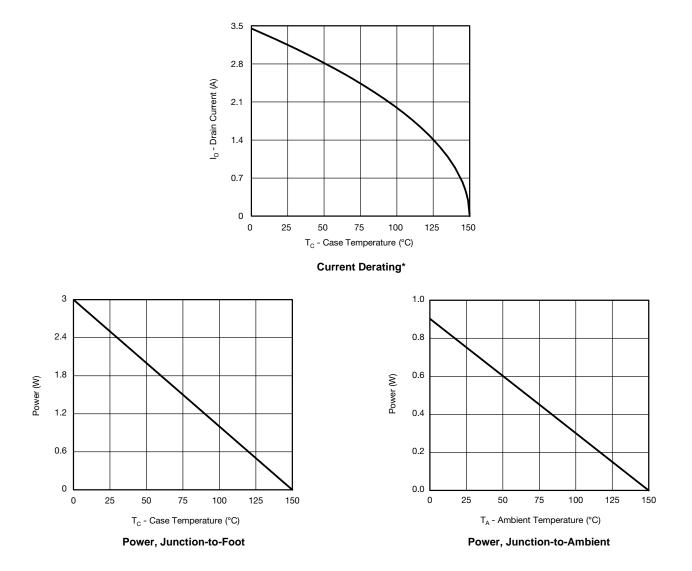






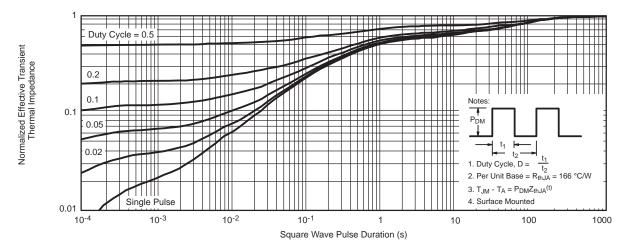
Safe Operating Area



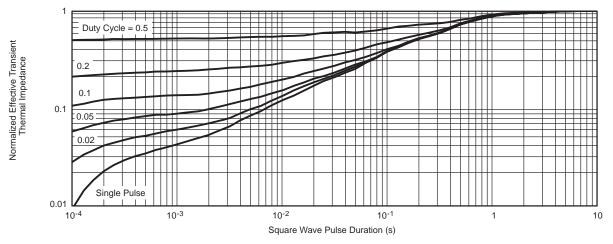


* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





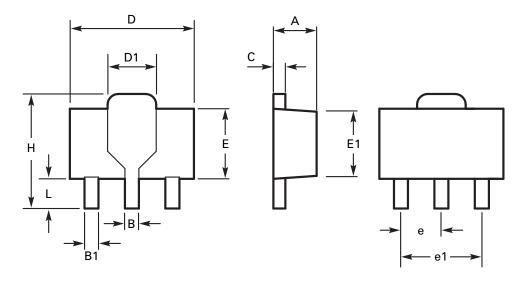
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



Package outline - SOT89



| DIM | Millimeters | | Inc | Inches DI | | Millimeters | | Inc | hes |
|-----|-------------|------|-------|-----------|----|-------------|------|-----------|-------|
| | Min | Max | Min | Max | | Min | Max | Min | Max |
| А | 1.40 | 1.60 | 0.550 | 0.630 | E | 2.29 | 2.60 | 0.090 | 0.102 |
| В | 0.44 | 0.56 | 0.017 | 0.022 | E1 | 2.13 | 2.29 | 0.084 | 0.090 |
| B1 | 0.36 | 0.48 | 0.014 | 0.019 | е | 1.50 BSC | | 0.059 BSC | |
| С | 0.35 | 0.44 | 0.014 | 0.017 | e1 | 3.00 BSC | | 0.118 | BSC |
| D | 4.40 | 4.60 | 0.173 | 0.181 | Н | 3.94 | 4.25 | 0.155 | 0.167 |
| D1 | 1.62 | 1.83 | 0.064 | 0.072 | L | 0.89 | 1.20 | 0.035 | 0.047 |

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches



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